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Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,782	MITA, KIYOSHI
Examiner	Art Unit
Chris C. Chu	2015

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	E21.505, 678, 787 & 698	5/16/2006	C.C.

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

SEARCH NOT		)
	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	5/16/2006	C.C.